

Irish Standard I.S. EN 61280-2-3:2009

Fibre optic communication subsystem test procedures -- Part 2-3: Digital systems - Jitter and wander measurements (IEC 61280-2-3:2009 (EQV))

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EUROPEAN STANDARD

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English version

Fibre optic communication subsystem test procedures Part 2-3: Digital systems Jitter and wander measurements

(IEC 61280-2-3:2009)

Procédures d'essai des sous-systèmes de télécommunications à fibres optiques -Partie 2-3: Systèmes numériques -Mesures des gigues et des dérapages (CEI 61280-2-3:2009) Prüfverfahren für Lichtwellenleiter-Kommunikationsuntersysteme -Teil: 2-3: Digitale Systeme -Messung von Jitter und Wander (IEC 61280-2-3:2009)

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European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

EN 61280-2-3:2009

- 2 -

Foreword

The text of document 86C/885/FDIS, future edition 1 of IEC 61280-2-3, prepared by SC 86C, Fibre optic systems and active devices, of IEC TC 86, Fibre optics, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61280-2-3 on 2009-08-01.

This document supersedes EN 61280-2-5:1998.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2010-05-01

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2012-08-01

Annex ZA has been added by CENELEC.

The contents of the corrigendum of March 2010 have been included in this copy.

Endorsement notice

The text of the International Standard IEC 61280-2-3:2009 was approved by CENELEC as a European Standard without any modification.

EN 61280-2-3:2009

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60825-1	_1)	Safety of laser products - Part 1: Equipment classification and requirements	EN 60825-1	2007 ²⁾
ITU-T Recommendation G.813	_ ¹⁾	Timing characteristics of SDH equipment slave clocks (SEC)	-	-

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¹⁾ Undated reference.

²⁾ Valid edition at date of issue.

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- 2 - 61280-2-3 © IEC:2009(E)

CONTENTS

FO	REWO	ORD	5
1	Scop	oe	7
	1.1	Types of jitter measurements	7
	1.2	Types of wander measurements	7
2	Norm	native references	7
3	Term	ns and definitions	7
4	Gene	eral considerations	11
	4.1	Jitter generation	11
		4.1.1 Timing jitter	
		4.1.2 Alignment jitter	11
		4.1.3 Other effects	12
	4.2	Effects of jitter on signal quality	12
	4.3	Jitter tolerance	12
	4.4	Waiting time jitter	13
	4.5	Wander	14
5	Jitter	test procedures	14
	5.1	General considerations	14
		5.1.1 Analogue method	14
		5.1.2 Digital method	14
	5.2	Common test equipment	15
	5.3	Safety	16
	5.4	Fibre optic connections	
	5.5	Test sample	
6	Jitter	tolerance measurement procedure	
	6.1	Purpose	
	6.2	Apparatus	
	6.3	BER penalty technique	
		6.3.1 Equipment connection	
		6.3.2 Equipment settings	
		6.3.3 Measurement procedure	
	6.4	Onset of errors technique	
		6.4.1 Equipment connection	
		6.4.2 Equipment settings	
	0.5	6.4.3 Measurement procedure	
	6.5	Jitter tolerance stressed eye receiver test	
		6.5.1 Purpose	
		6.5.2 Apparatus	
7	Mood	6.5.3 Sinusoidal jitter template techniquesurement of jitter transfer function	
′		•	
	7.1	General	
	7.2	Apparatus	
	7.3	Basic technique	
		7.3.1 Equipment connection	
		7.3.2 Equipment settings	
	7.4	Analogue phase detector technique	
	1.4	Alialogue pliase detector technique	دے

61280-2-3 © IEC:2009	(E) – 3	_
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		7.4.1	Equipment connections	23
		7.4.2	Equipment settings	23
		7.4.3	Measurement procedure	24
		7.4.4	Measurement calculations	24
8	Meas	uremen	t of output jitter	24
	8.1	Genera	al	24
	8.2	Equipn	nent connection	24
		8.2.1	Equipment settings	
		8.2.2	Measurement procedure	
		8.2.3	Controlled data	
9	Meas		t of systematic jitter	
	9.1		itus	
	9.2	• •	echnique	
	0.2	9.2.1	Equipment connection	
		9.2.2	Equipment settings	
		9.2.3	Measurement procedure	
10	BERT		echnique	
10			itus	
	10.2		echnique	
			Equipment connection	
			Equipment settings	
4.4	1:44		Measurement process	
11		-	tion technique	
			itus	
			nent connections	
			nent settings	
	11.4		rement procedure	
			Sampling oscilloscope:	
			Real-time oscilloscope	
12	Meas	uremen	t of wander	33
			tus	
	12.2	Basic t	echnique	33
		12.2.1	Equipment connection	33
		12.2.2	Equipment settings	34
			Measurement procedure	
13	Meas	uremen	t of wander TDEV tolerance	35
	13.1	Intent		35
	13.2	Appara	ıtus	35
	13.3	Basic t	echnique	35
	13.4	Equipn	nent connection	35
		13.4.1	Wander TDEV tolerance measurement for the test signal of EUT	35
		13.4.2	Wander TDEV tolerance measurement for timing reference signal of EUT	36
	13.5	Equipn	nent settings	
			rement procedure	
14			t of wander TDEV transfer	
	14.1	Appara	ıtus	37
			nent connection	

- 4 - 61280-2-3 © IEC:2009(E)

		Wander TDEV transfer measurement for the test signal of EUT	37
	14.2.2	Wander TDEV transfer measurement for timing reference signal of EUT	37
14.	3 Equipn	nent settings	
14.	4 Measu	rement procedure	38
15 Tes	st results		38
		tory information	
		ole information	
Bibliogr	raphy		40
Figure	1 – Jitter	generationgeneration	11
•		ple of jitter tolerance	
-		and wander generator	
•		and wander measurement	
_		stress generator	
Figure	6 – Jitter	tolerance measurement configuration: bit error ratio (BER) penalty	
Figure ¹	7 – Jitter	tolerance measurement configuration: Onset of errors technique	19
Figure	8 – Equip	ment configuration for stressed eye tolerance test	20
Figure	9 – Meası	urement of jitter transfer function: basic technique	22
Figure	10 – Meas	surement of Jitter transfer: analogue phase detector technique	23
Figure	11 – Outp	ut jitter measurement	25
Figure	12 – Syst	ematic jitter measurement configuration: basic technique	26
Figure	13 – Mea	surement of the pattern-dependent phase sequence xi	27
		T scan bathtub curves (solid line for low jitter, dashed line for high	28
,		pment setup for the BERT scan	
•	•	Dirac jitter model	
_		pment setup for jitter separation measurement	
		surement of time interval error	
•		chronized wander measurement configuration	
•	•	synchronized wander measurement configuration	
Figure :	21 – Wan	der TDEV tolerance measurement configuration for the test signal of	
Figure :	22 – Wan	der TDEV tolerance measurement configuration for the timing signal	
Figure :	23 – Wan	der TDEV transfer measurement configuration for the test signal of	
		der TDEV transfer measurement configuration for the timing signal of	38

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- 5 -

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –

Part 2-3: Digital systems – Jitter and wander measurements

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61280-2-3 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

The text of this standard is based on the following documents:

FDIS	Report on voting
86C/885/FDIS	86C/905/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

A list of all parts of the IEC 61280-2 series, published under the general title *Fibre optic communication subsystem test procedures – Digital systems,* can be found on the IEC website.

-6-

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The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version may be published at a later date.

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-7-

FIBRE OPTIC COMMUNICATION SUBSYSTEM TEST PROCEDURES –

Part 2-3: Digital systems – Jitter and wander measurements

1 Scope

This part of IEC 61280 specifies methods for the measurement of the jitter and wander parameters associated with the transmission and handling of digital signals.

1.1 Types of jitter measurements

This standard covers the measurement of the following types of jitter parameters:

- a) jitter tolerance
 - 1) sinusoidal method
 - 2) stressed eye method
- b) jitter transfer function
- c) output jitter
- d) systematic jitter
- e) jitter separation

1.2 Types of wander measurements

This standard covers the measurement of the following types of wander parameters:

- a) non-synchronized wander
- b) TDEV tolerance
- c) TDEV transfer
- d) synchronized wander

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60825-1, Safety of laser products – Part 1: Equipment classification and requirements

ITU-T Recommendation G.813, Timing characteristics of SDH equipment slave clocks (SEC)

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

NOTE See also IEC 61931.



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